Electronic Acknowledgement Receipt					
EFS ID:	1036749				
Application Number:	10624712				
Confirmation Number:	3646				
Title of Invention:	TECHNIQUE FOR FORMING CONTACTS FOR BURIED DOPED REGIONS IN A SEMICONDUCTOR DEVICE				
First Named Inventor:	Ralf van Bentum				
Customer Number:	23720				
Filer:	J. Mike Amerson/Mary Paul				
Filer Authorized By:	J. Mike Amerson				
Attorney Docket Number:	2000.106700				
Receipt Date:	02-MAY-2006				
Filing Date:	22-JUL-2003				
Time Stamp:	17:14:42				
Application Type:	Utility				
International Application Number:					

Payment information:

Submitted with Payment	no
------------------------	----

File Listing:

Document Number	Document Description	File Name	File Size(Bytes)	Multi Part	Pages
1	Miscellaneous Incoming Letter	Letter_re_issue_fee.pdf	126886	no	1

Warnings:								
Information:								
2	Issue Fee Payment Recorded	Fees_Transmittal_PTOL_85. pdf	64648	no	1			
Warnings:								
Information:								
		Total Files Size (in bytes):	191534					

This Acknowledgement Receipt evidences receipt on the noted date by the USPTO of the indicated documents, characterized by the applicant, and including page counts, where applicable. It serves as evidence of receipt similar to a Post Card, as described in MPEP 503.

New Applications Under 35 U.S.C. 111

If a new application is being filed and the application includes the necessary components for a filing date (see 37 CFR 1.53(b)-(d) and MPEP 506), a Filing Receipt (37 CFR 1.54) will be issued in due course and the date shown on this Acknowledgement Receipt will establish the filing date of the application.

National Stage of an International Application under 35 U.S.C. 371

If a timely submission to enter the national stage of an international application is compliant with the conditions of 35 U.S.C. 371 and other applicable requirements a Form PCT/DO/EO/903 indicating acceptance of the application as a national stage submission under 35 U.S.C. 371 will be issued in addition to the Filing Receipt, in due course.